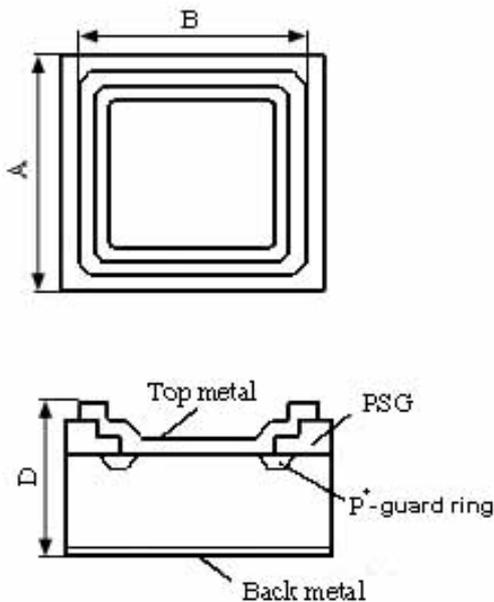


**SCHOTTKY DIODES KDN-15040C.
PRELIMINARY.**



Rev.1. Feb. 2010

| | | | | |
|--|----------------------------------|-------------|---------------------|-------------------------|
| | 15A/40V. Die Size-123mil. | | | |
| Electrical Characteristics | Symbol | Unit | Spec. limit | Die Sort |
| Breakdown Voltage @ $I_R=10mA$ | V_{BR} | V | 40 | 45 |
| Average Rectified Forward Current | $I_{F(AV)}$ | A | 15,0 | - |
| DC Forward Voltage @ 25°C, $I_F=15,0A$ | V_F | V | 0,52 | 0,50 0,48- typ. |
| Maximum Reverse Current @ 25°C, $V_R=45V$ 25°C, $V_R=40V$ 125°C, $V_R=40V$ | I_R | mA | - 0,300 200,0 | 0,350 0,250 180,0 |
| Peak Forward Surge Current 8,3ms single half sine-wave superimposed on rated load (JEDEC METHOD) | I_{FSM} | A | 250 | - |
| Peak Repetitive Reverse Surge Current @2,0µs, f=1kHz., $T_J<150°C$. | I_{RRM} | A | 4,5 | |
| Electrostatic Discharge Voltage. JEDEC Method. ESD HBM. Contact. | ESD | kV | ±8 (contact) | |
| Voltage Rate of Change | dV/dt | V/µS | 10.000 | |
| Operating Junction Temperature | T_J | °C | 150 | |



| DIM | ITEM | µm |
|-------------------|---------------------|--------------|
| A_x A_y | Wafer Form Die Size | 3120 3120 |
| B_x B_y | Top Metal Size | 2980 2980 |
| D | Thickness | 300max. |
| Scribe line Width | | 80 |

Top metal: a) **Al** – for Wire Bonding;
b) **Al-Ni-Ag** – for Soldering.

Backside metal: **Ti-Ni-Ag**.